

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FLYNN ET AL.	
		Examiner /BINH K. TIEU/	Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0242238	12-2004	Wang et al.	455/456.1
*	C	US-2003/0148774	08-2003	Naghian et al.	455/456
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**NON-PATENT DOCUMENTS**

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